## Application/Control No. O9/522,449 Applicant(s)/Patent Under Reexamination KIM ET AL. Examiner Chanh Nguyen Applicant(s)/Patent Under Reexamination KIM ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,422,807	06-1995	Mitra et al.	700/79
	B.	US-5,532,935	07-1996	Ninomiya et al.	700/296
	С	US-5,786,801	07-1998	Ichise, Atsushi	345/102
	D	US-6,115,032	09-2000	Kotha et al.	345/211
	Е	US-6,535,985	03-2003	Oshima et al.	713/323
	F	US-			
	G	US-			
	Н	US-		***************************************	
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N						
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	Р						
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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